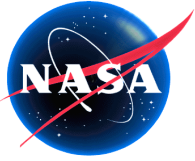


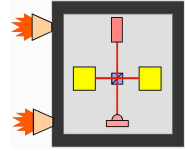
The ST7 Interferometer

Andreas Kuhnert
Robert Spero

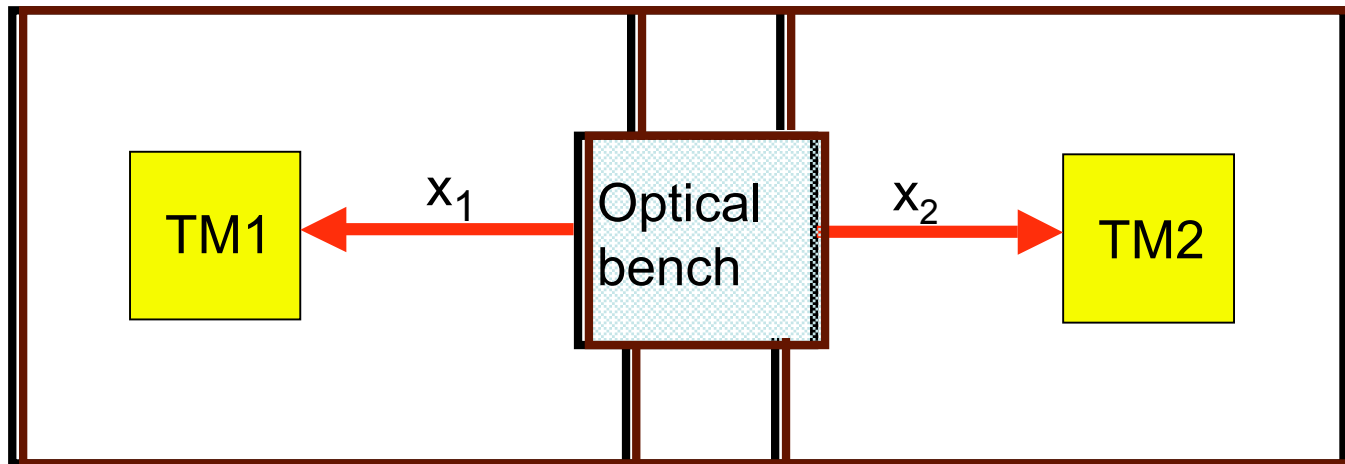
Jet Propulsion Laboratory
California Institute of Technology



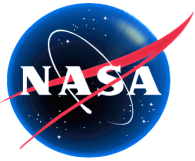
ST7 Concept



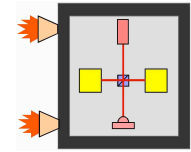
- Measure suspended masses within spacecraft
- Test thruster performance in drag-free control
- Hitch ride on LISA Pathfinder



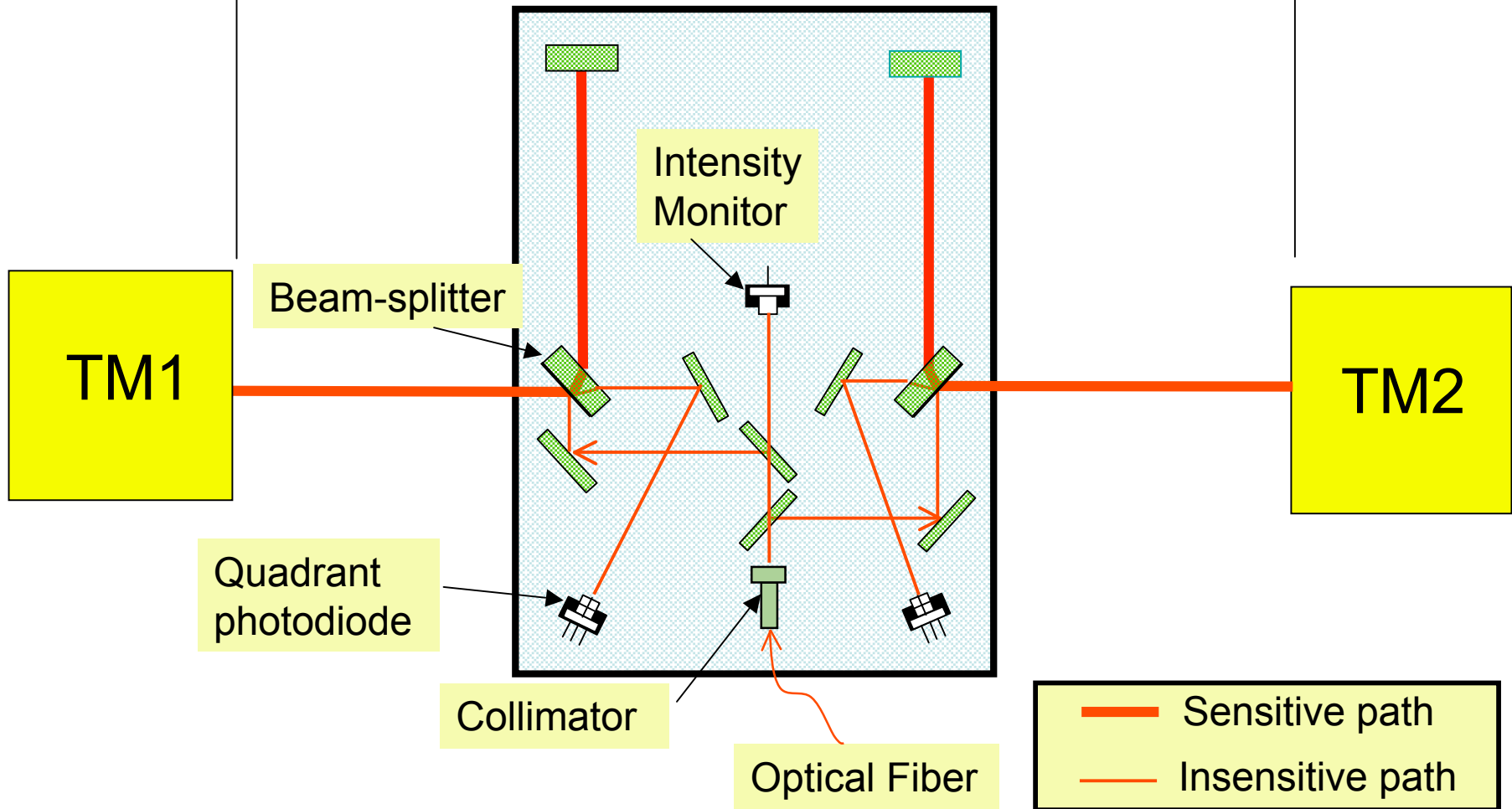
- Interferometer optical bench fixed to spacecraft
- x_1 and x_2 measured separately; $x_1 + x_2$ is low-noise

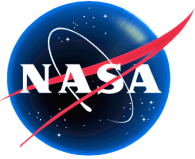


Optical Bench

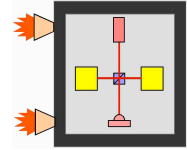


20 cm





Interferometer Features



Beam diameter 1 mm, Rayleigh range 70 cm, sensitive path lengths 10 cm.

No modulators, phasemeters, intensity stabilization, or frequency stabilization.

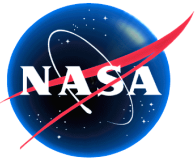
Requires test mass to be positioned near mid-fringe.

Intensity monitored, noise removed in data analysis.

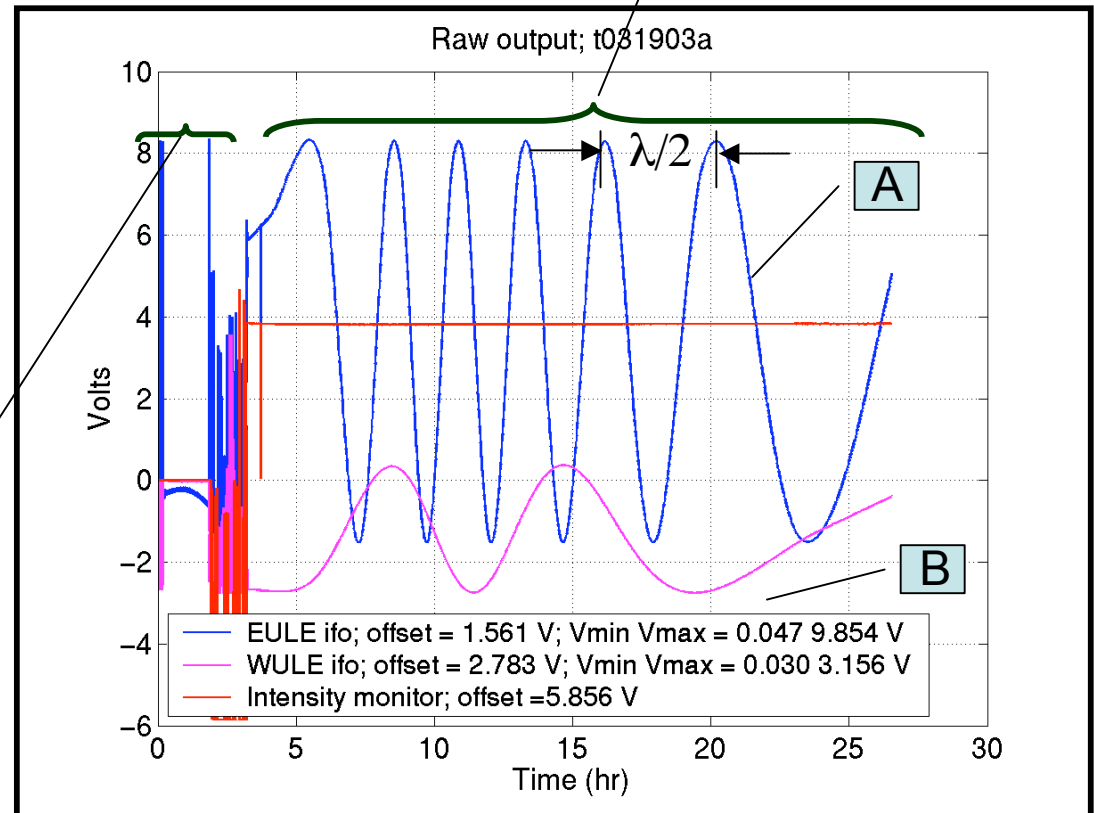
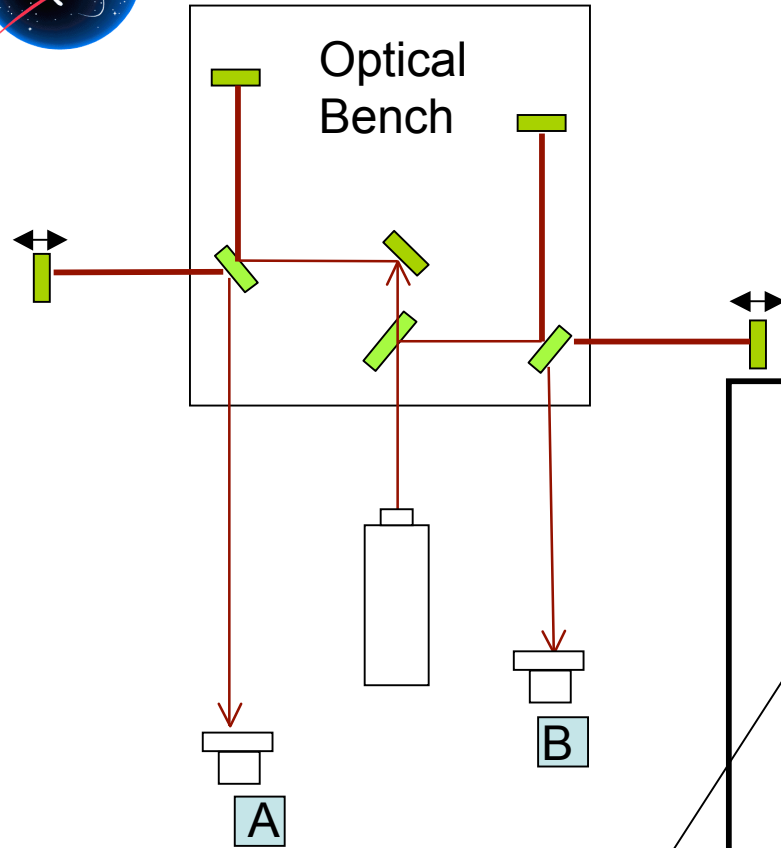
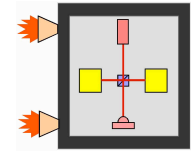
Separate measurements of both bench/test-mass distances.

Quadrant photodiodes monitor total fringe signal, and two axes of alignment.

Automatic alignment, autonomous operation.



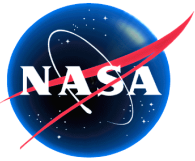
Homodyne Signal



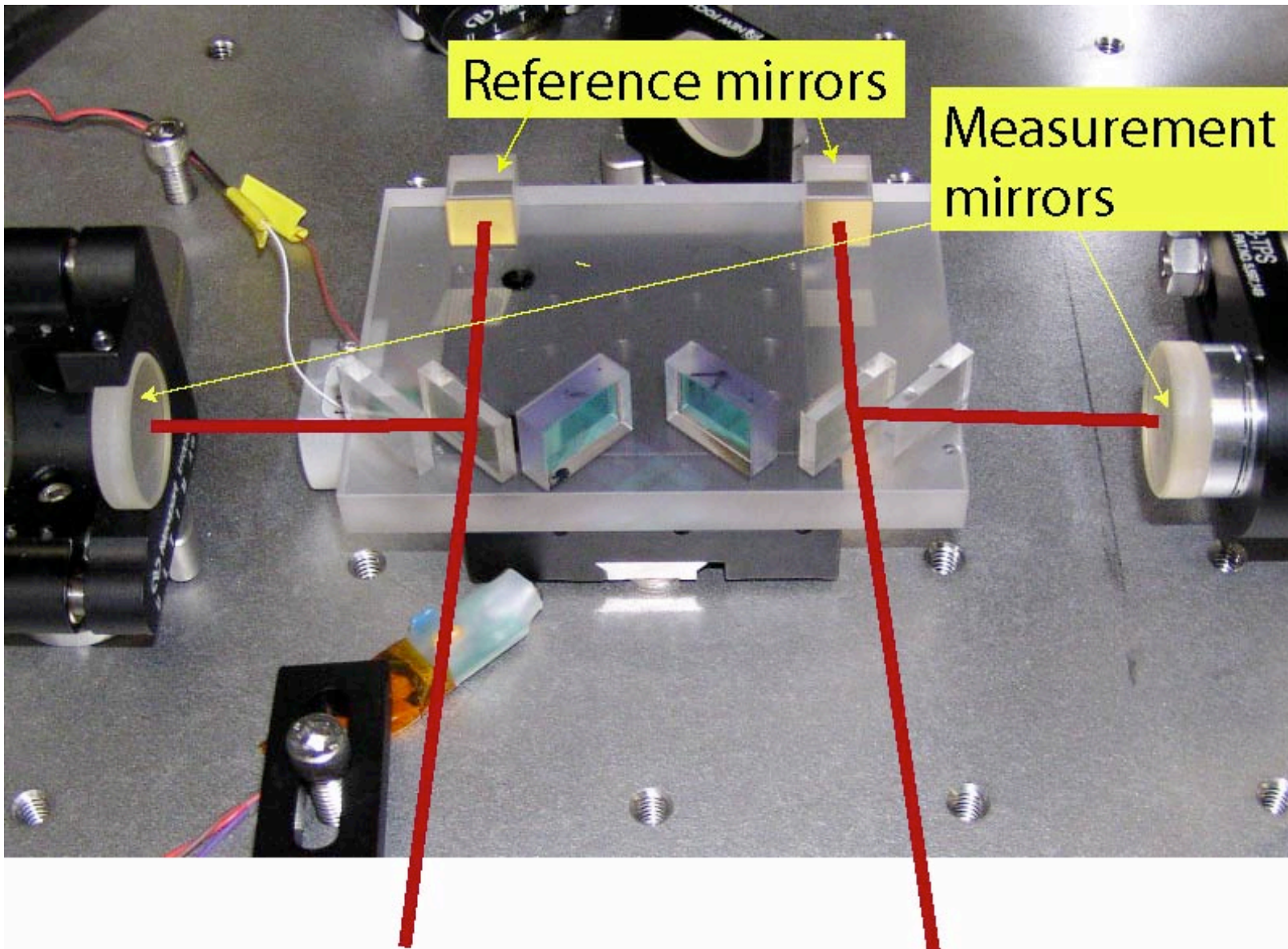
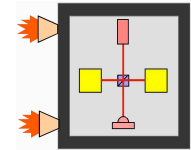
Manual Alignment

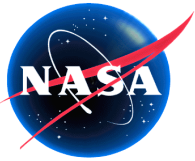
Thermal Expansion

ST7 Interferometer

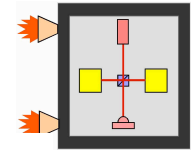


Contacted Optics in Vacuum Chamber

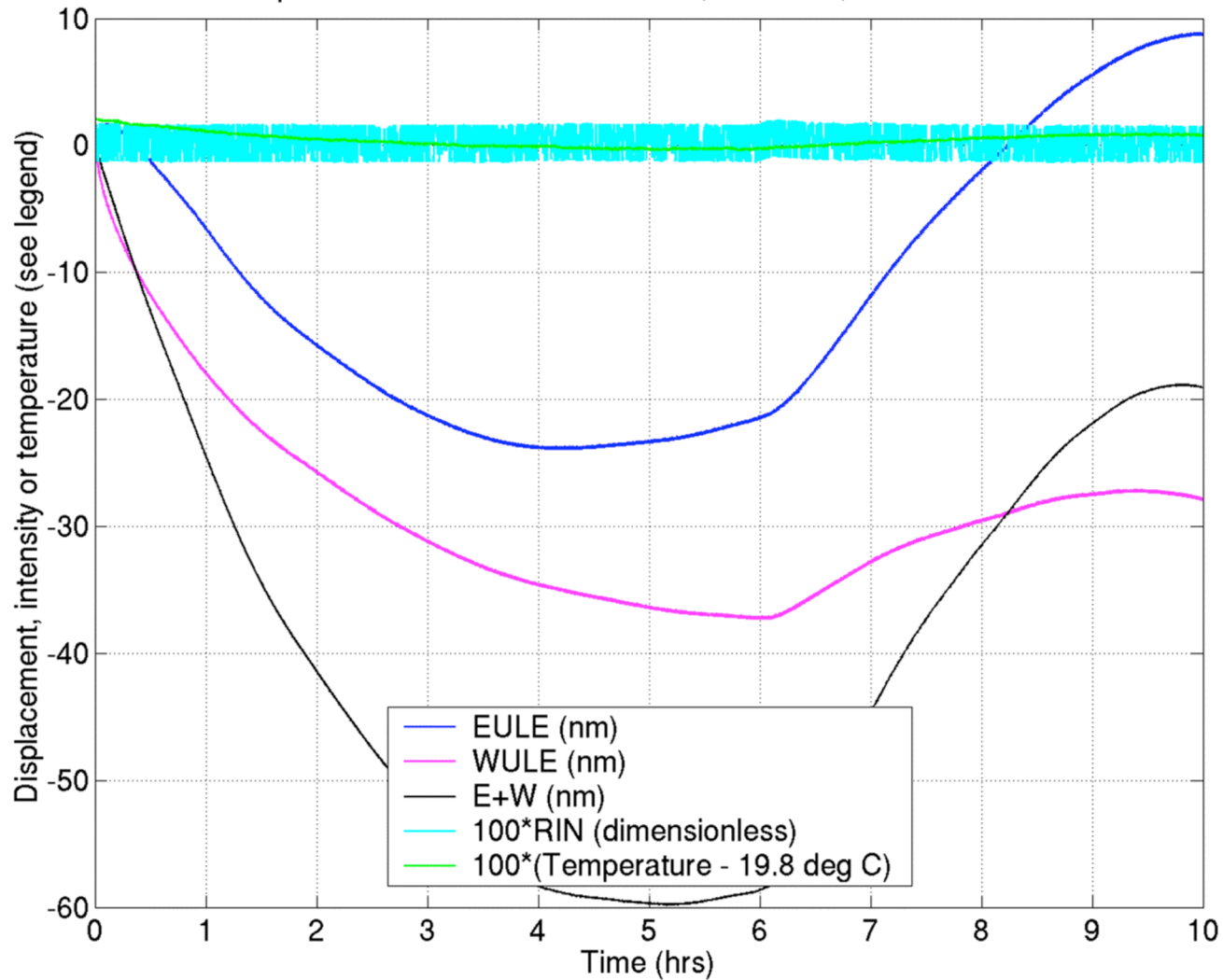


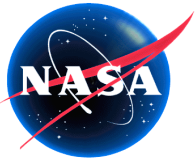


Testbed Drift

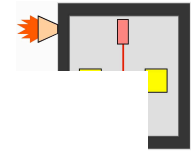


Temperature monitor inside chamber; t041803a; $0 < t < 10$ hr-N10

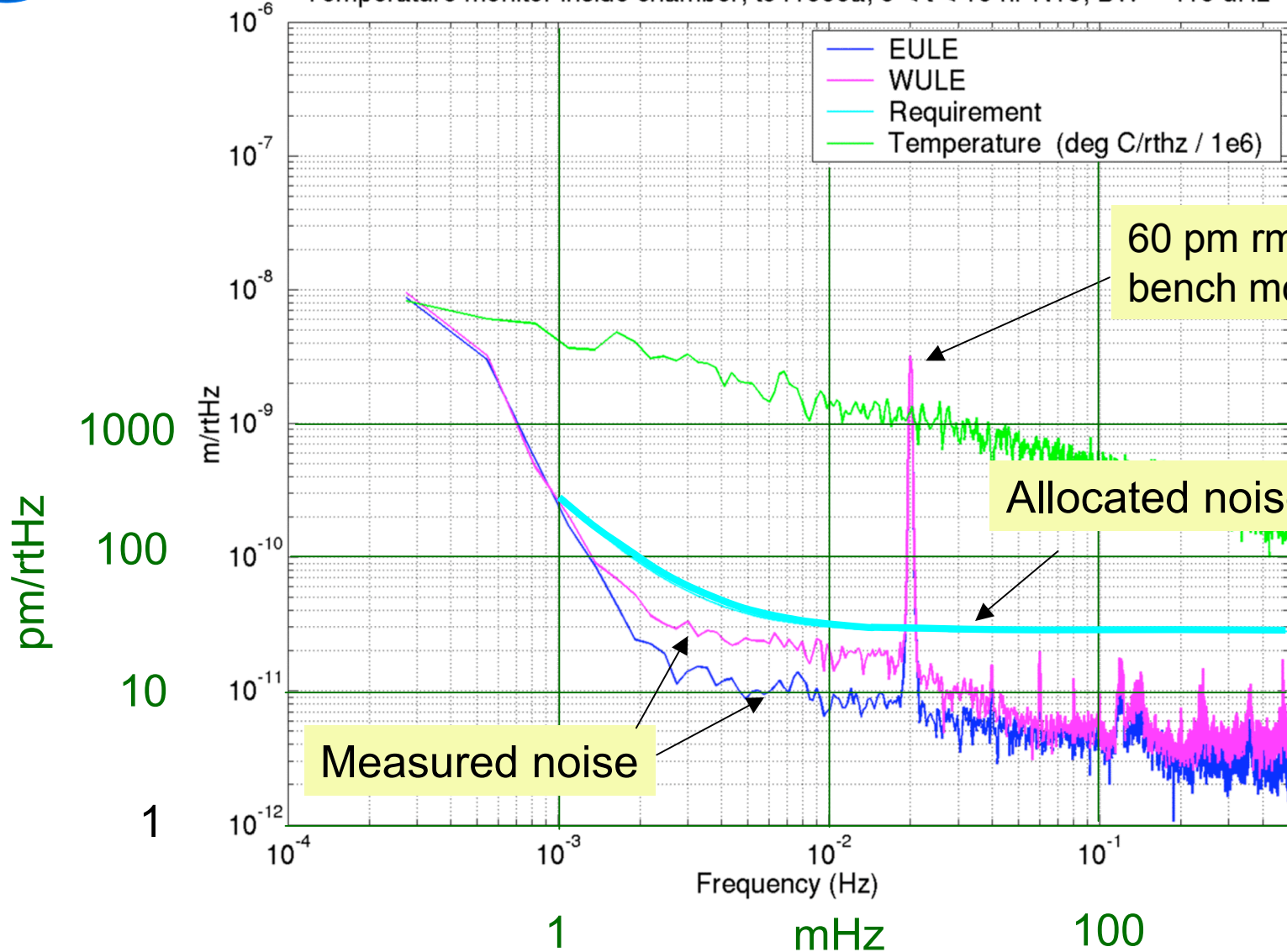




Testbed Noise



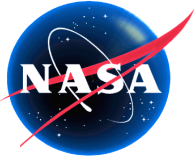
Temperature monitor inside chamber; t041803a; $0 < t < 10$ hr-N10; BW = 410 uHz



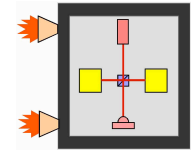
60 pm rms optical bench modulation

Allocated noise

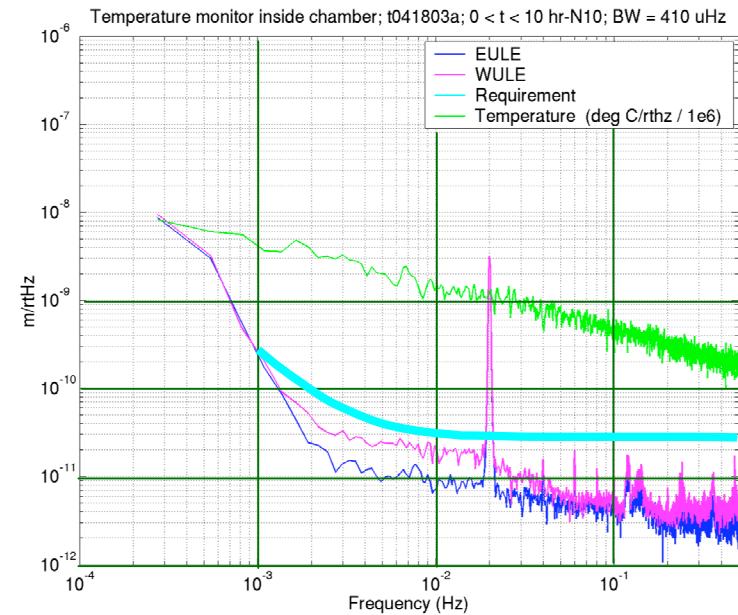
Measured noise

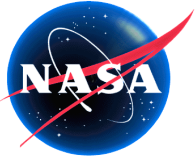


Measurements Demonstrate:

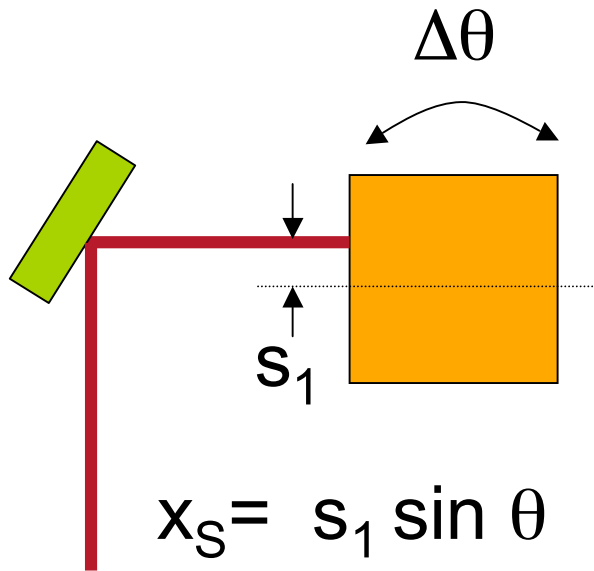
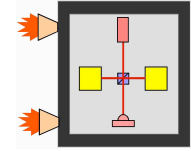


1. Analog electronics and ADC noise adequately low
2. Thermal sensitivity probably adequately low
3. Bench motion suppression typically x200, without calibration (x1000 needed)
4. Frequency stabilization not needed
5. Intensity noise can be suppressed in data analysis



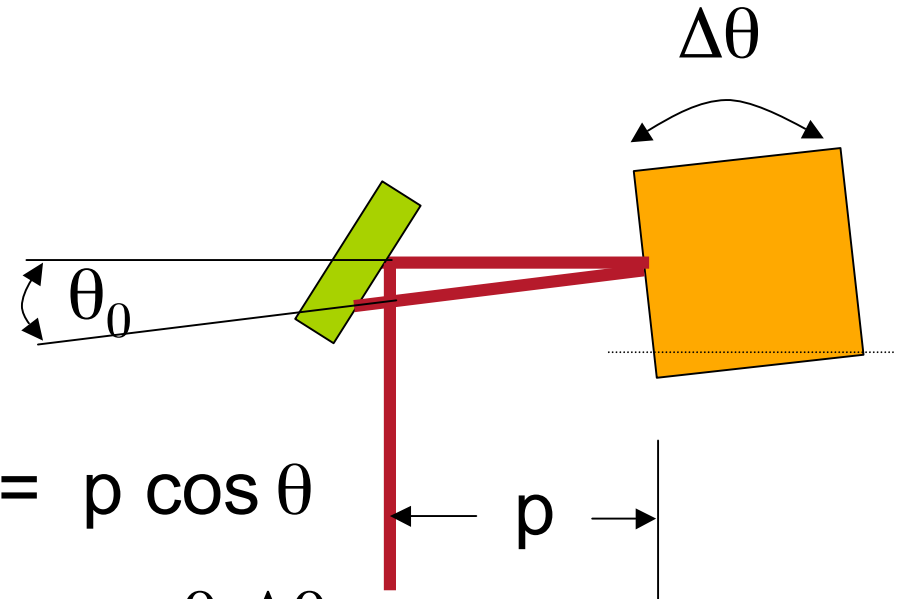


Alignment Sensitivity 1: Geometric error



$$x_S = s_1 \sin \theta$$

$$\Delta x_S = s_1 \Delta \theta$$

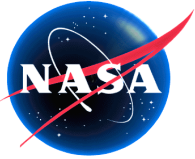


$$x_C = p \cos \theta$$

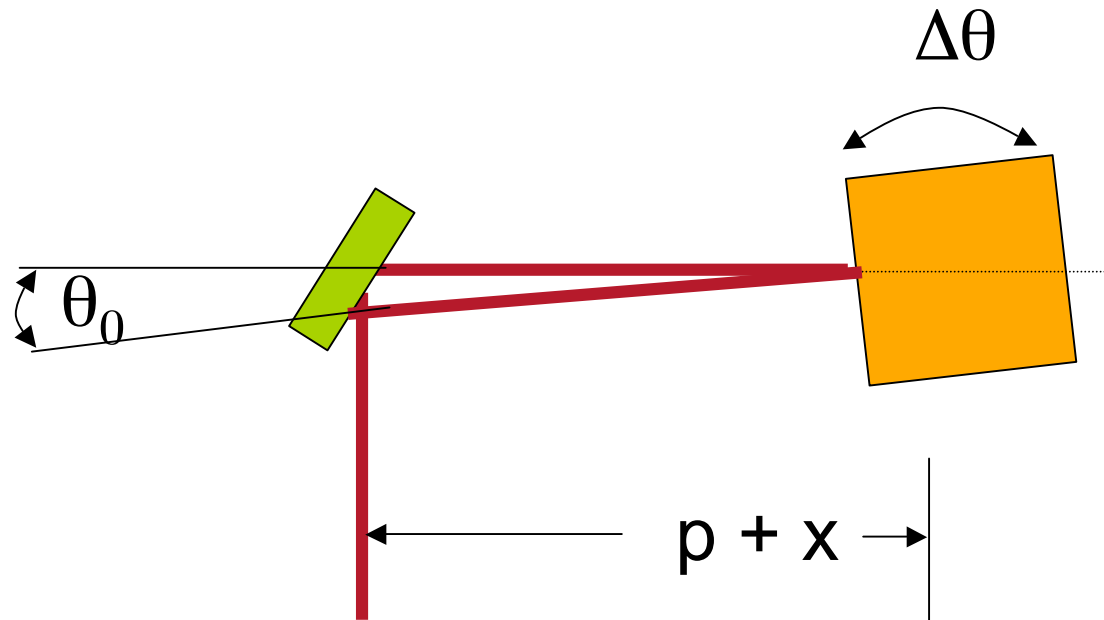
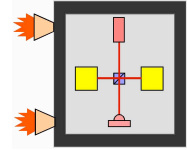
$$\Delta x_C = p \theta_0 \Delta \theta$$

$$s_1 = 40 \mu; p = 10 \text{ cm}; \theta_0 = 400 \mu\text{rad}$$

Errors are correlated, and of same order: $s_1 \sim p \theta_0$

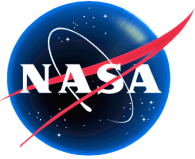


Alignment Sensitivity 2: Fringe position error

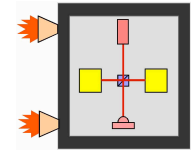


$$\Delta x_x = \alpha x \theta_0 \Delta \theta,$$
$$\alpha = (\pi w / \lambda)^2 = 2.2 \times 10^6,$$

w=beam radius



Total angle-jitter noise



$$\frac{dx}{d\theta} \approx h + \theta [\alpha x - p]$$
$$\tilde{x}(f) \approx \tilde{\theta}(f) (h + \theta [\alpha x - p])$$

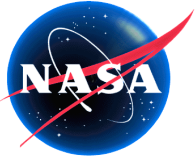
Fringe center error, 30 nm

Misalignment, 400 μ rad

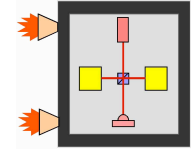
Transverse error, 40 μ m

Test mass jitter, 1 μ rad/rthz

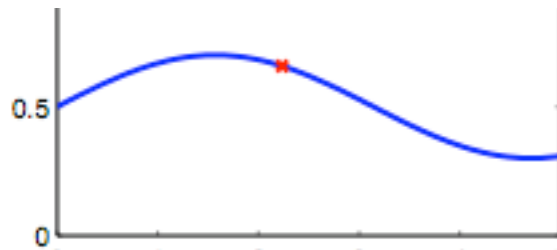
Displacement noise, 30 pm/rthz



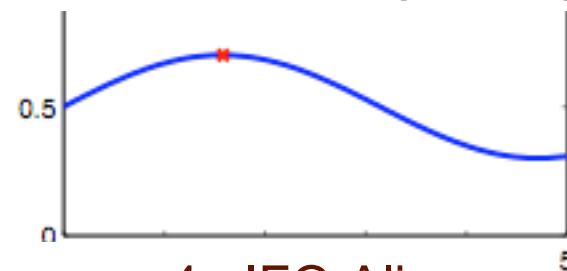
Initialization



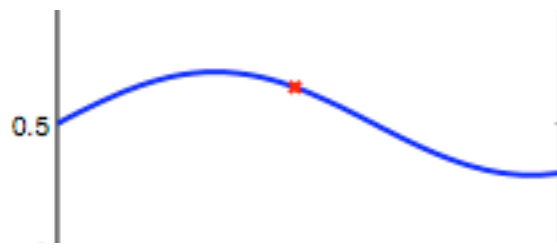
1. Starting state



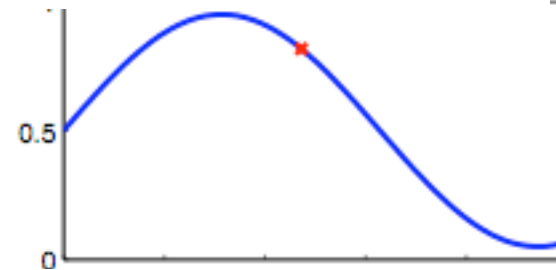
2. IFO finds bright fringe



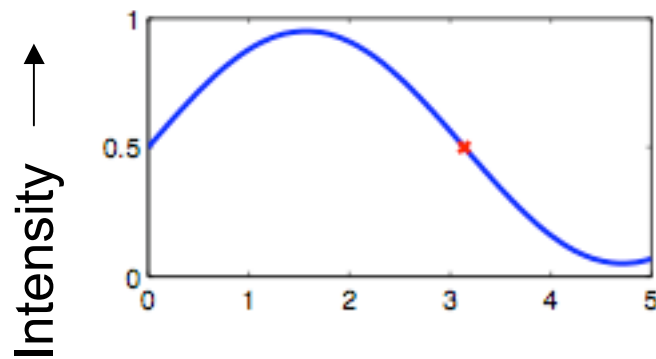
3. GRS moves to quarter fringe

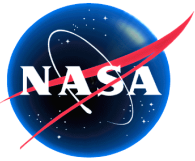


4. IFO Aligns

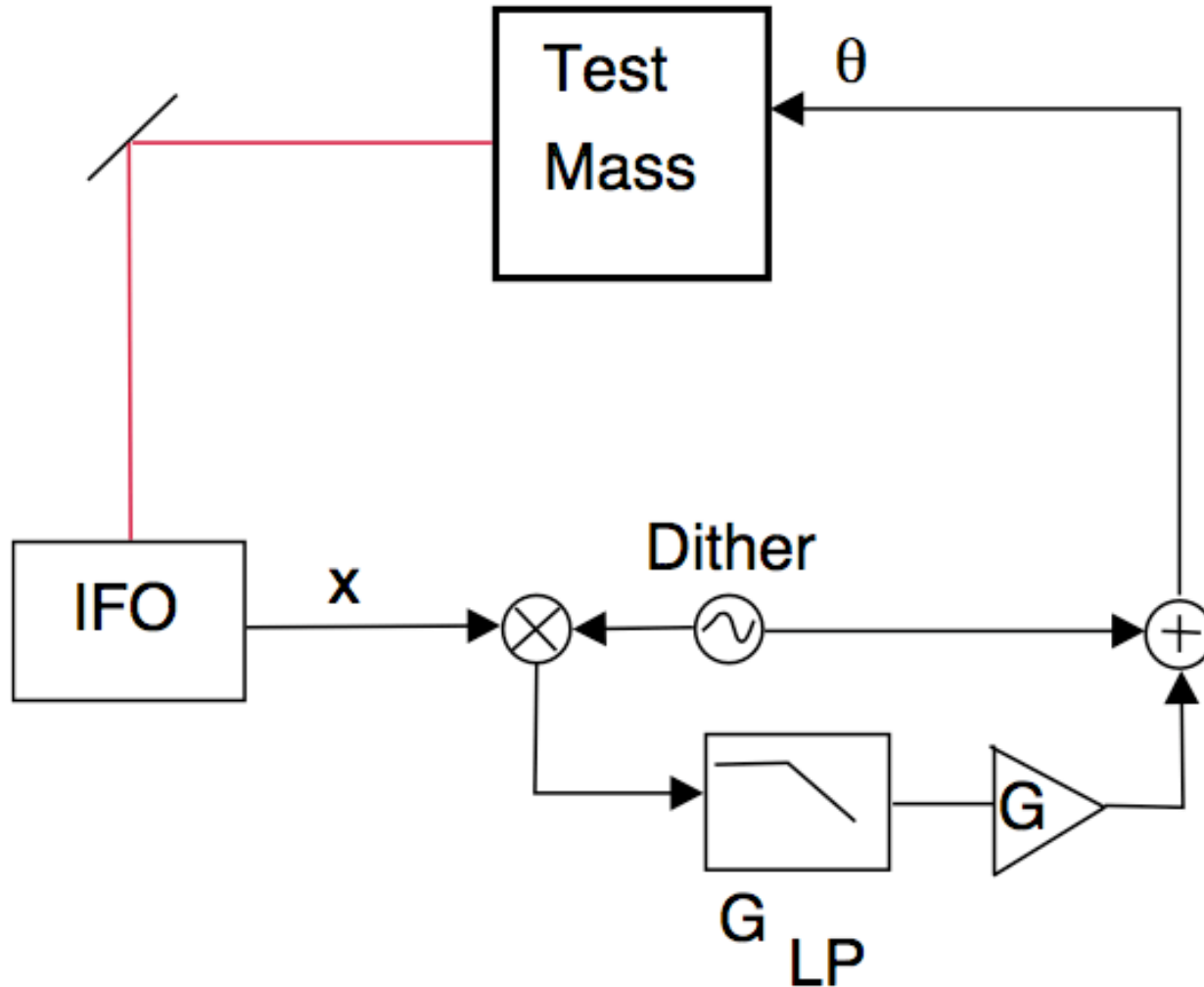
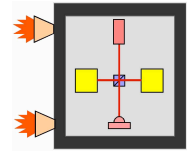


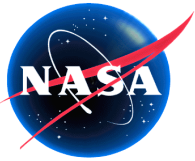
5. GRS to half fringe



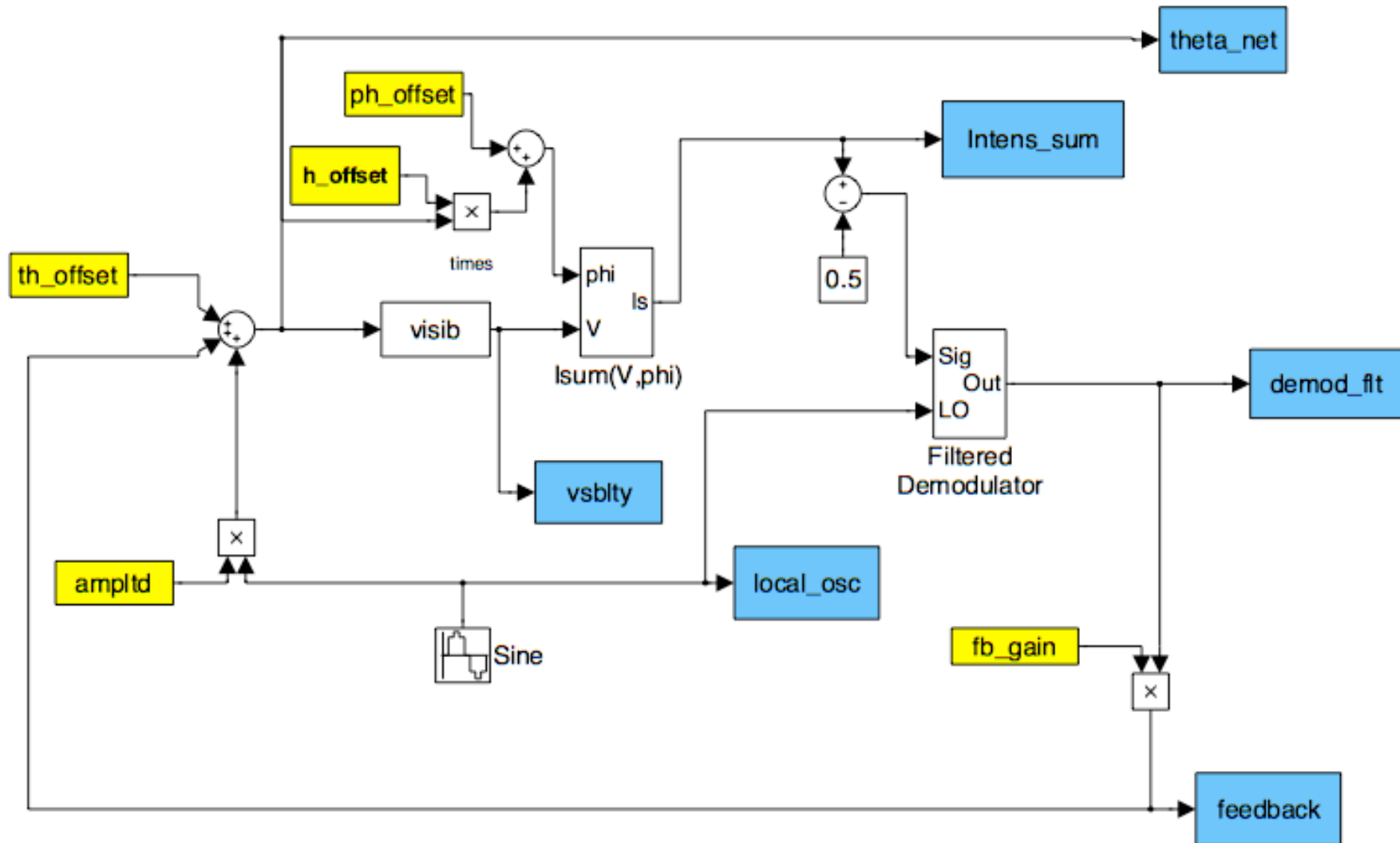
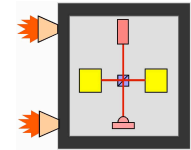


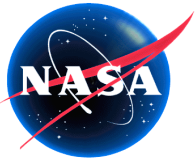
Dithered alignment -- concept





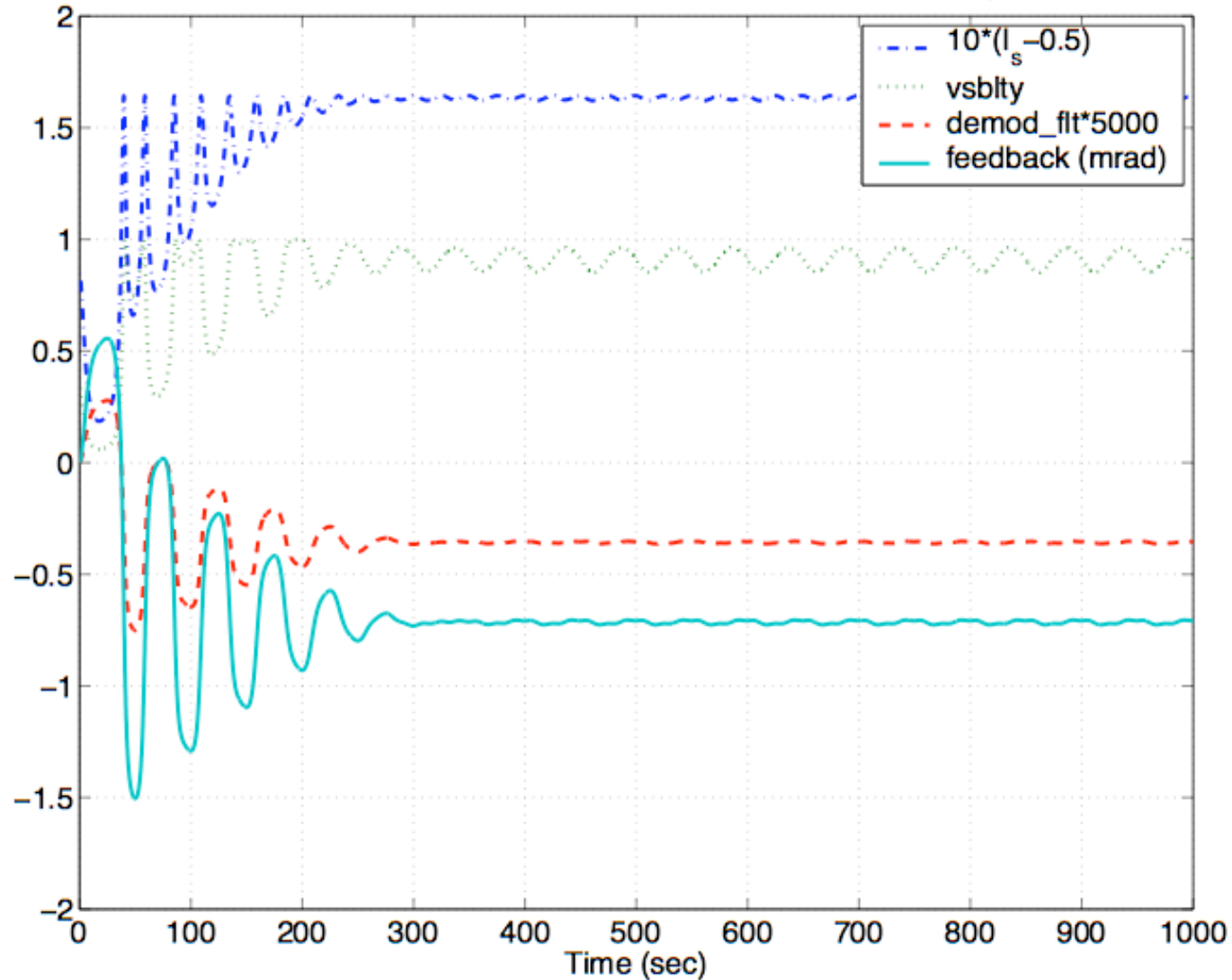
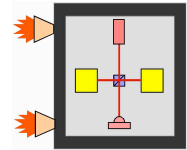
Dithered alignment -- Simulink model

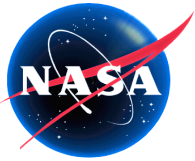




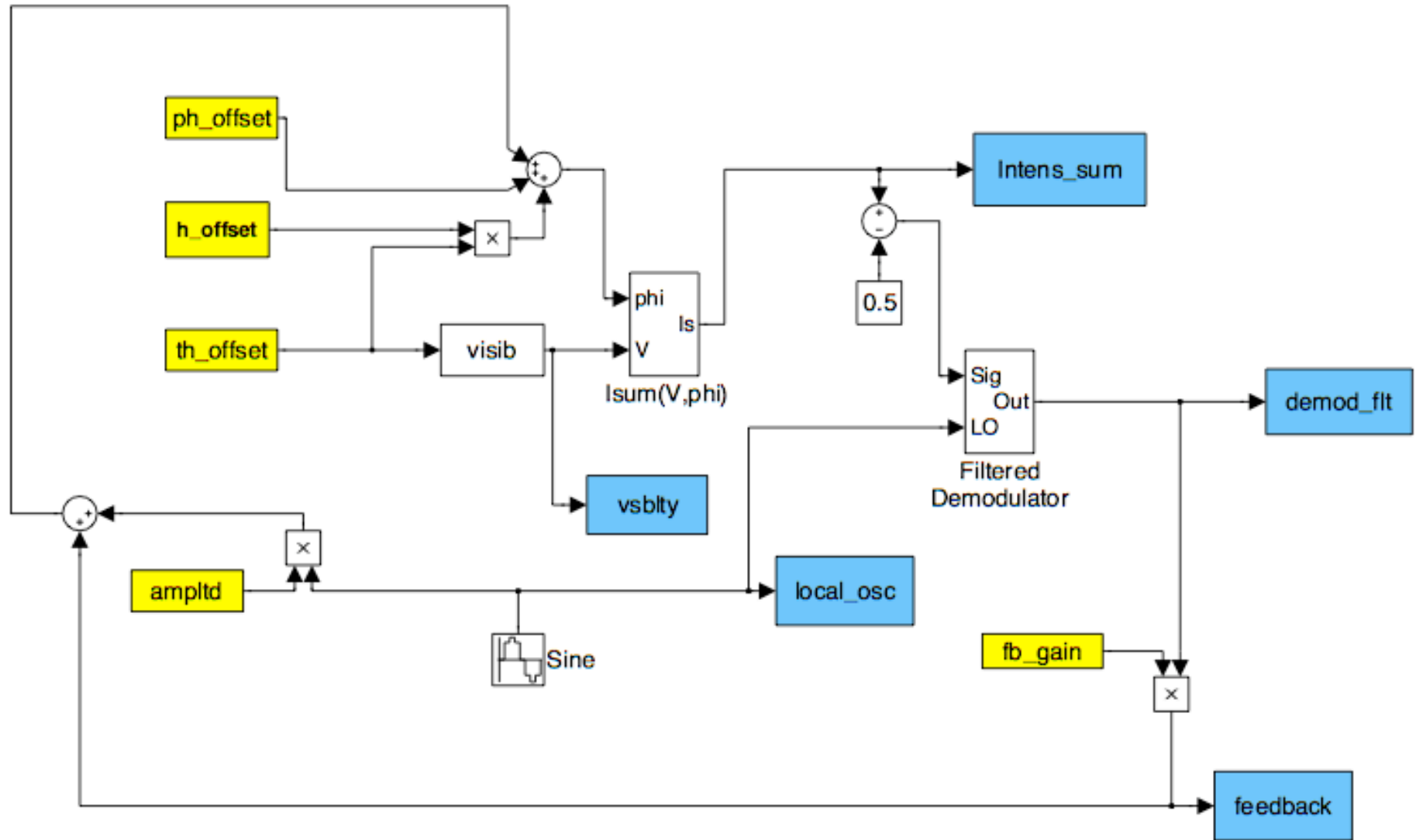
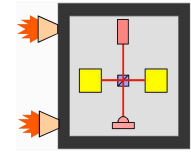
Dithered alignment -- Simulink run

th_offset = 1.0e-03; ph_offset = 0.3; h_offset = 20 μ m
ampltd = 1.0e-04; fmod = 0.02 HzLP, 1-pole, 4.0e-05 Hz; fb_gain = 10.0

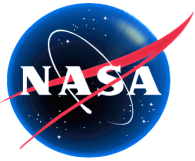




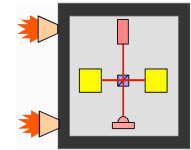
Bright fringe finder -- Simulink model



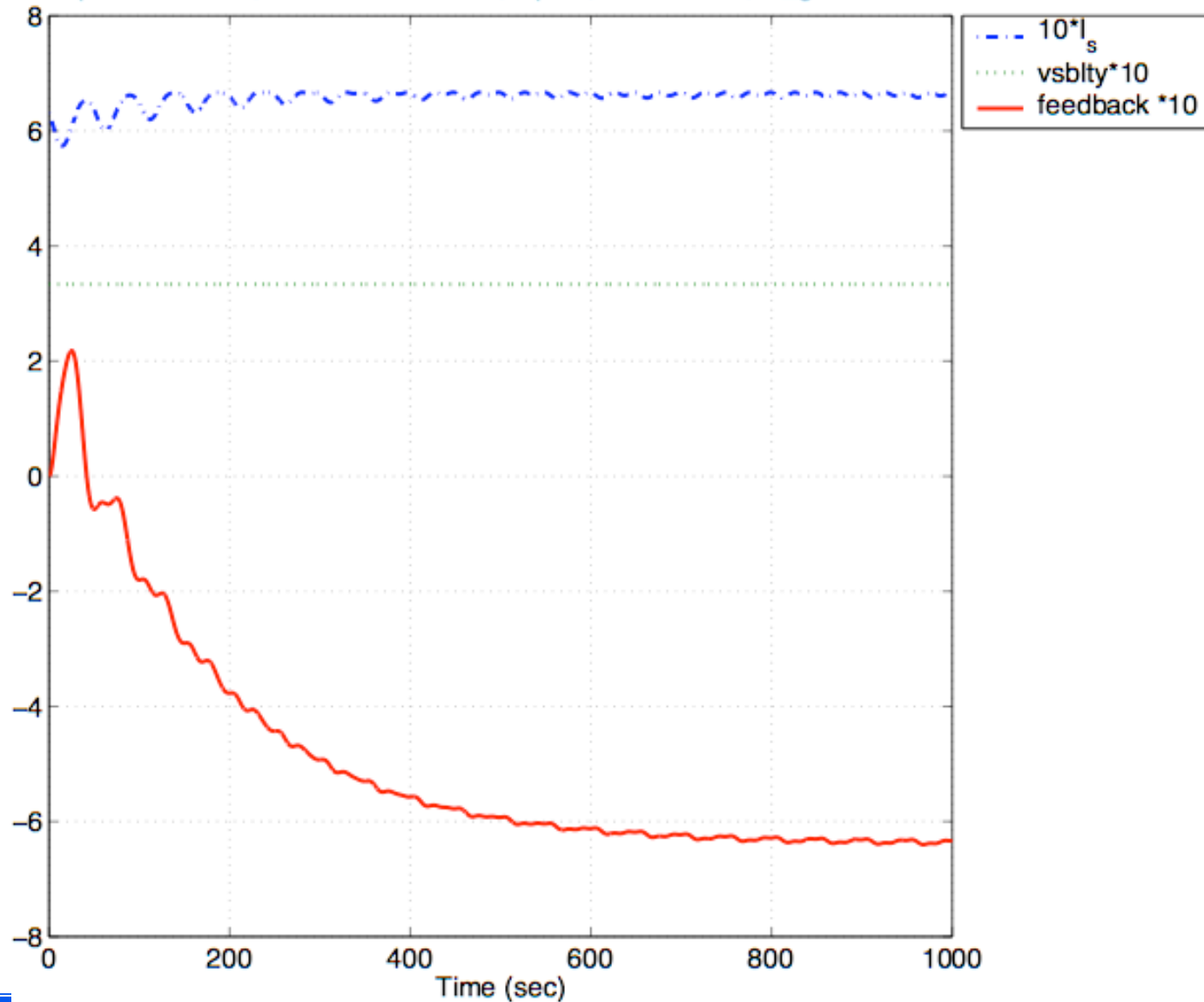
S17 Interferometer

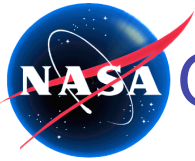


Bright fringe finder -- Simulink run

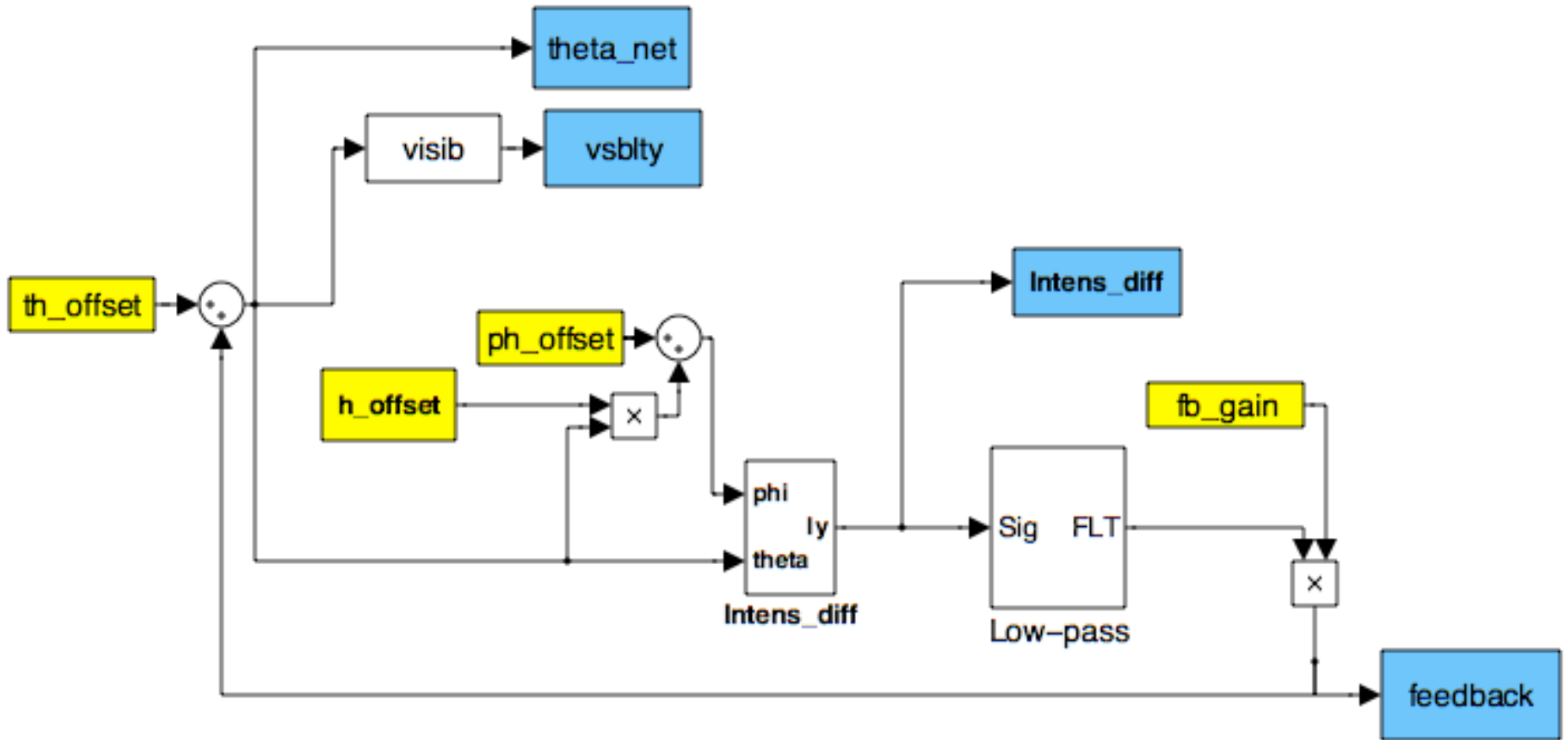
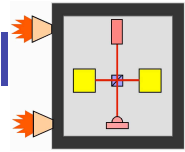


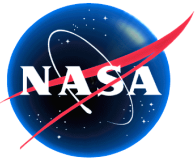
Fringe Dither -- th_offset = 1.0e-03; ph_offset = 2.0; h_offset = 20 um
ampltd = 3.0e-01; fmod = 0.02 Hz LP;1-pole, 4.0e-05 Hz; fb_gain = 1000.0



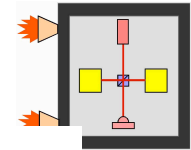


QPD difference alignment -- Simulink model

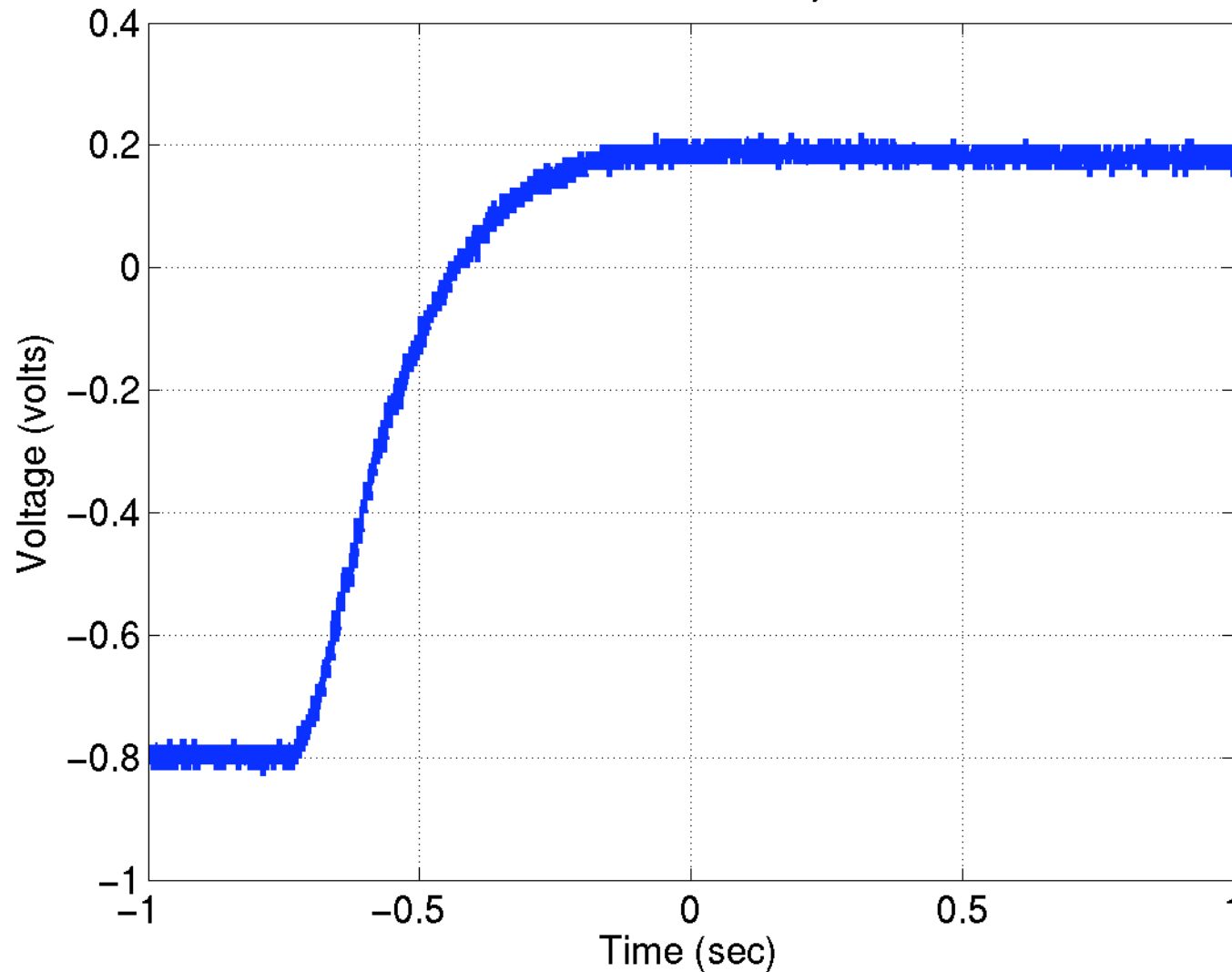


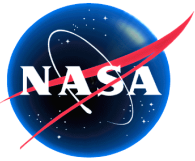


QPD difference alignment -- Experiment

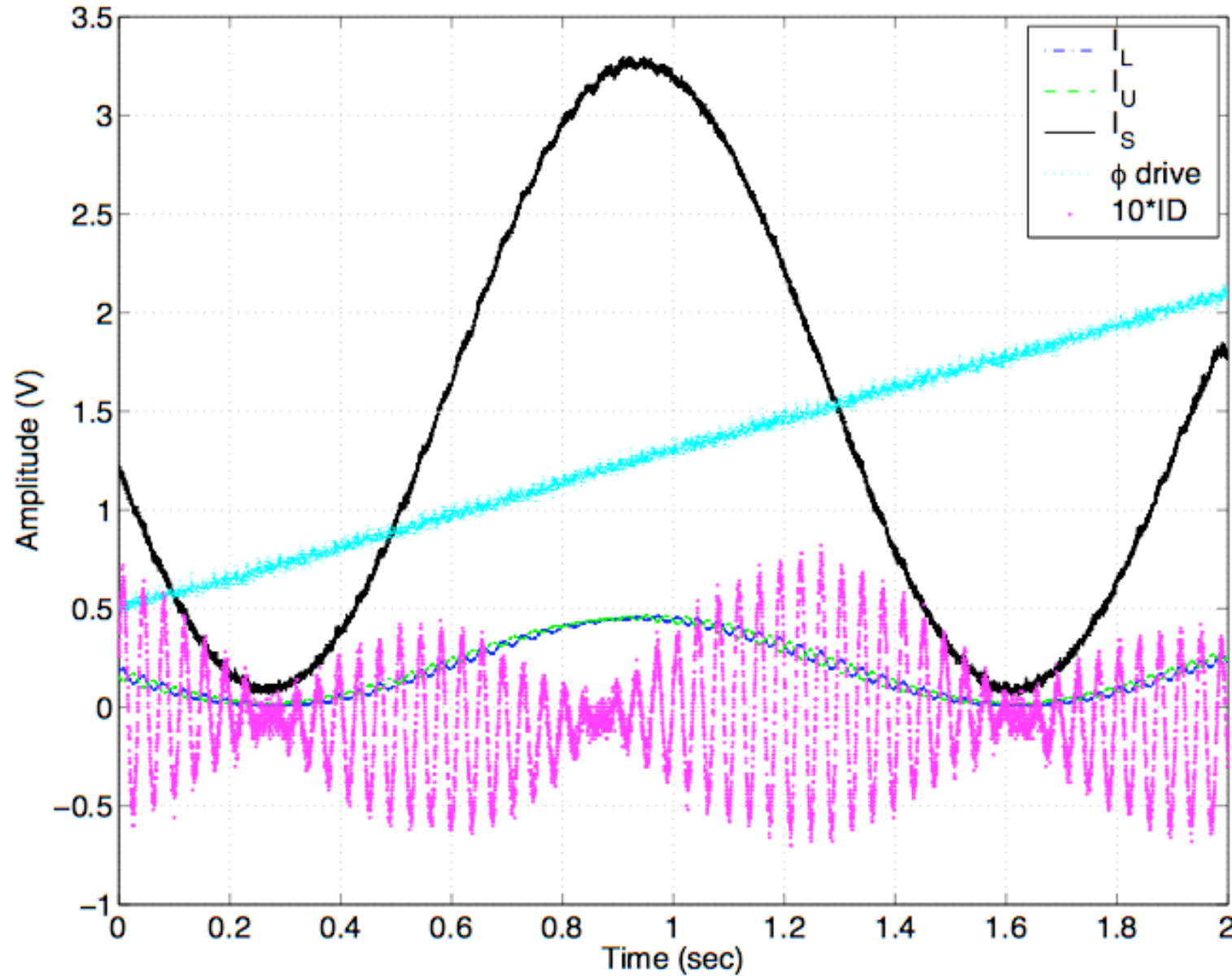
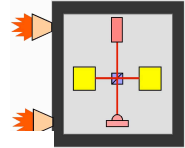


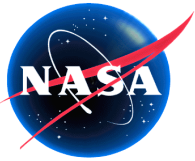
DAC output, step response, I_y Labview loop



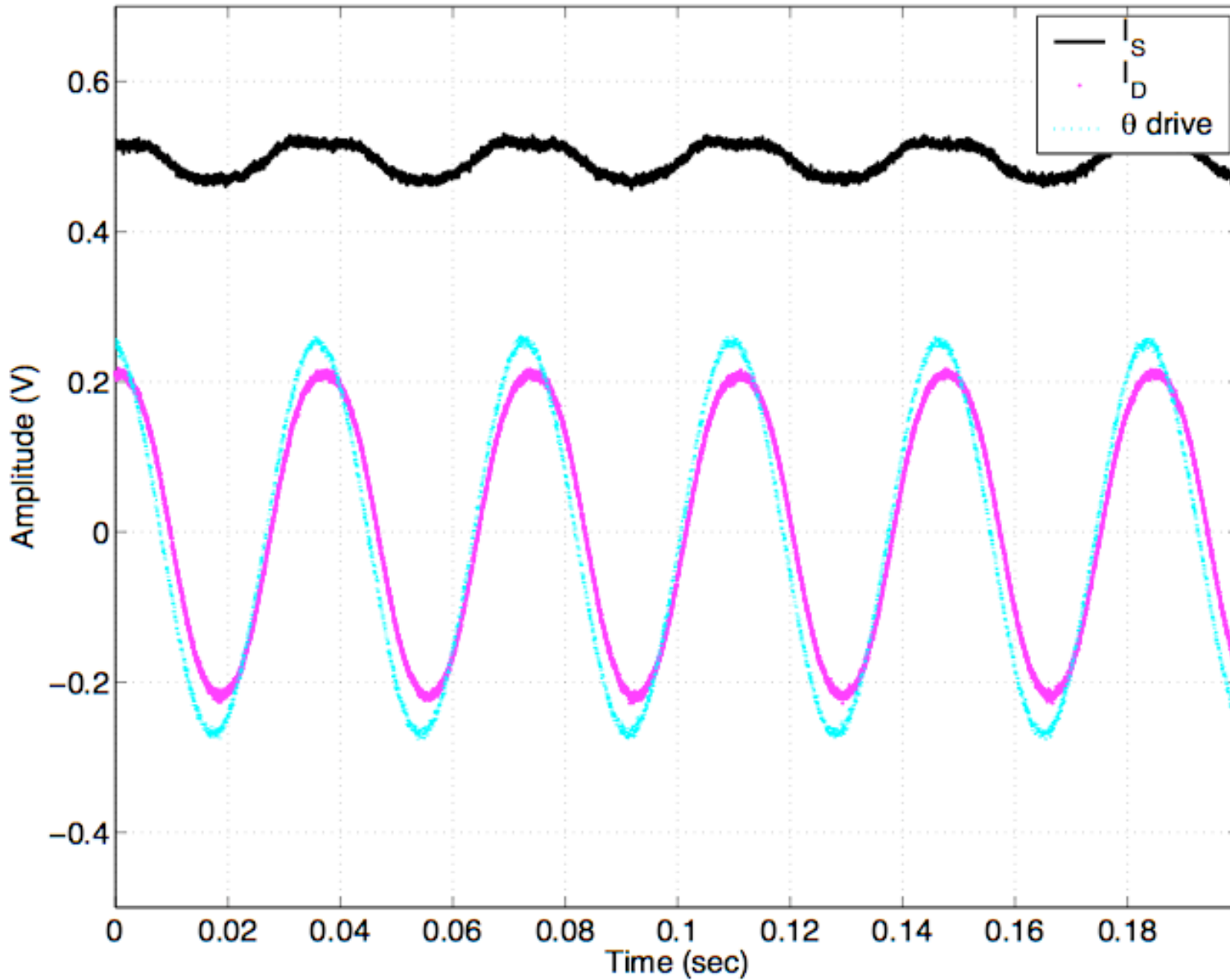
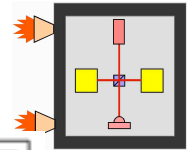


QPD difference signal alignment sensitivity

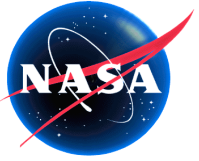




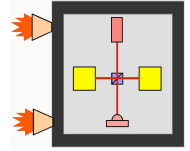
Sum vs. difference signals at half-fringe

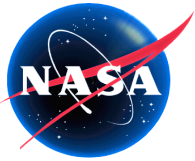


r

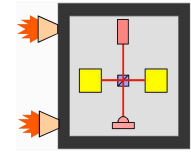


Backups

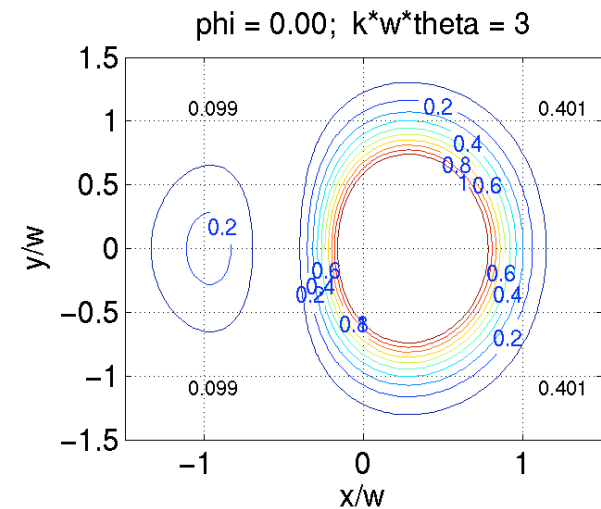
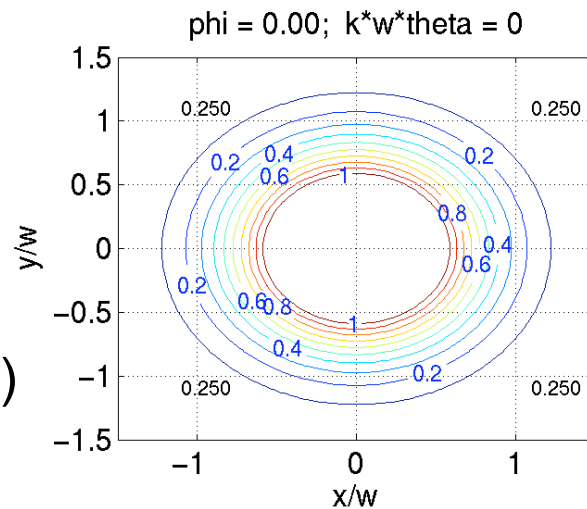
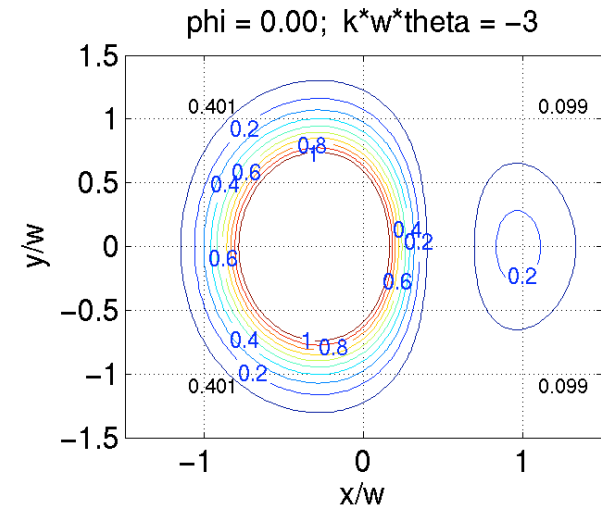
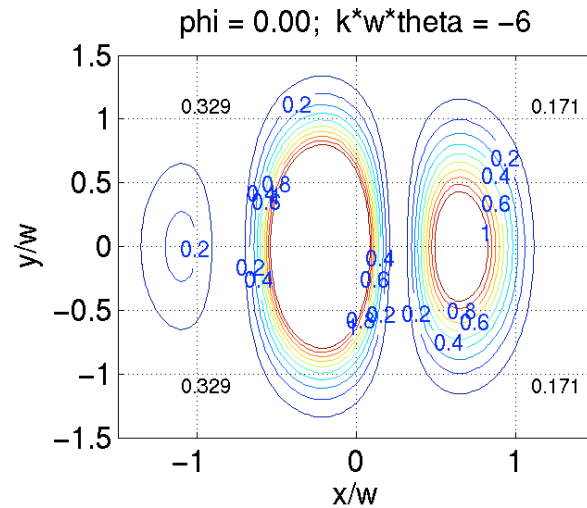


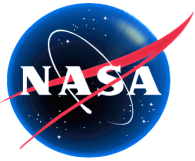


Intensity Pattern with Misalignment

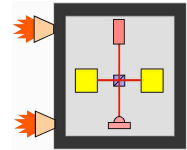


- Horizontal misalignment shown.
- Pattern insensitive to fringe offset near mid-fringe.
- Sample with 4 pixels (quadrant photodiode). Difference/sum response:
$$dQ/d\theta = \sqrt{8kw/\pi^3}$$

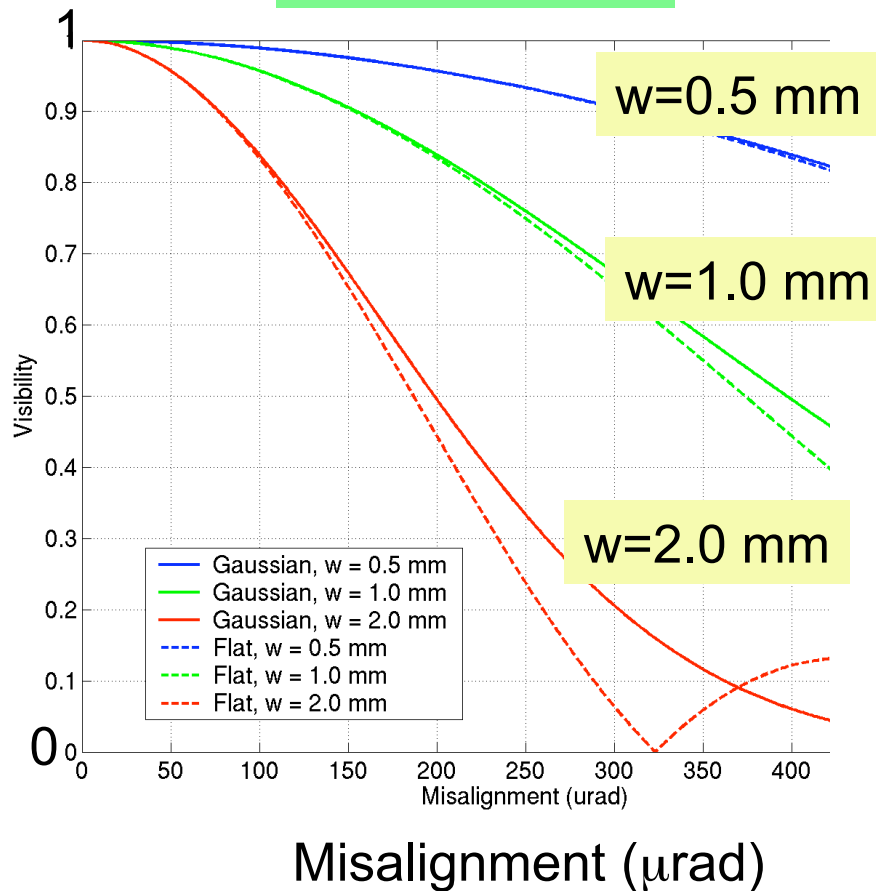




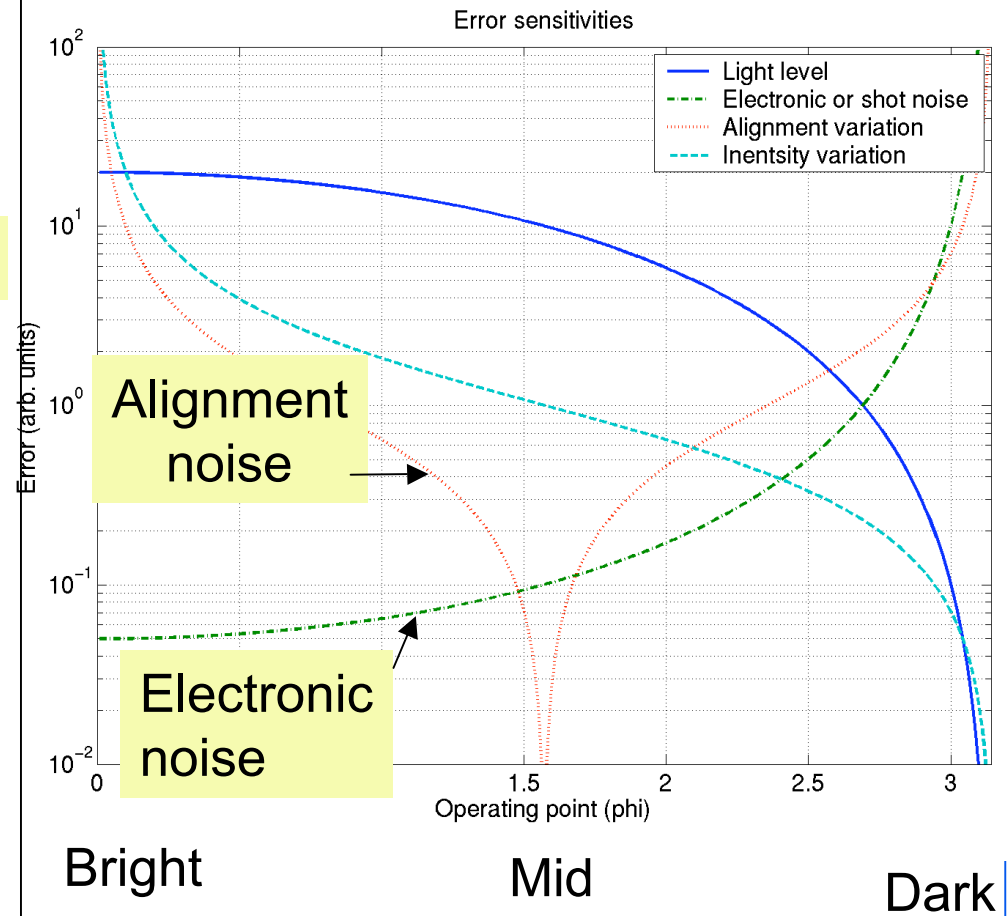
Static Misalignment and Static Longitudinal Error



Fringe Visibility



Error Sensitivity



ST7 Interferometer